



## FUNCTIONAL DESCRIPTION

**NOTE:** The functional description that follows describes operation using a 16.6667MHz crystal. Valid PLL loop divider values for different crystal or input frequencies are defined in the Input Frequency Characteristics, Table 6 NOTE 1.

The ICS8427-02 features a fully integrated PLL and therefore requires no external components for setting the loop bandwidth. A parallel-resonant, fundamental crystal is used as the input to the on-chip oscillator. The output of the oscillator is divided by 16 prior to the phase detector. With a 16.6667MHz crystal, this provides a 1.0417MHz reference frequency. The VCO of the PLL operates over a range of 250MHz to 500MHz. The output of the M divider is also applied to the phase detector.

The phase detector and the M divider force the VCO output frequency to be 2M times the reference frequency by adjusting the VCO control voltage. Note that for some values of M (either too high or too low), the PLL will not achieve lock. The output of the VCO is scaled by a divider prior to being sent to each of the LVPECL output buffers. The divider provides a 50% output duty cycle.

The ICS8427-02 powers up by default to 200MHz output frequency, using a 16.6667MHz crystal (M = 192, N = 2). The output frequency can be changed after power-up by using the serial interface to program the M feedback divider and the N output divider.

The relationship between the VCO frequency, the crystal frequency and the M divider is defined as follows:

$$f_{VCO} = \frac{f_{xtal}}{16} \times 2M$$

The M value and the required values of M0 through M8 are shown in Table 3B, Programmable VCO Frequency Function Table. Valid M values for which the PLL will achieve lock for a 16.6667MHz reference are defined as  $120 \leq M \leq 240$ . The frequency out is defined as follows:  $f_{out} = \frac{f_{VCO}}{N} = \frac{f_{xtal}}{16} \times \frac{2M}{N}$

Serial operation occurs when S\_LOAD is LOW. The shift register is loaded by sampling the S\_DATA bits with the rising edge of S\_CLOCK. The contents of the shift register are loaded into the M divider and N output divider when S\_LOAD transitions from LOW-to-HIGH. The M divide and N output divide values are latched on the HIGH-to-LOW transition of S\_LOAD. If S\_LOAD is held HIGH, data at the S\_DATA input is passed directly to the M divider and N output divider on each rising edge of S\_CLOCK. The serial mode can be used to program the M and N bits and test bits T1 and T0. The internal registers T0 and T1 determine the state of the TEST output as follows:

| T1 | T0                   | TEST Output                  |
|----|----------------------|------------------------------|
| 0  | 0                    | LOW                          |
| 0  | 1 (Power-up Default) | S_Data, Shift Register Input |
| 1  | 0                    | Output of M divider          |
| 1  | 1                    | CMOS Fout                    |

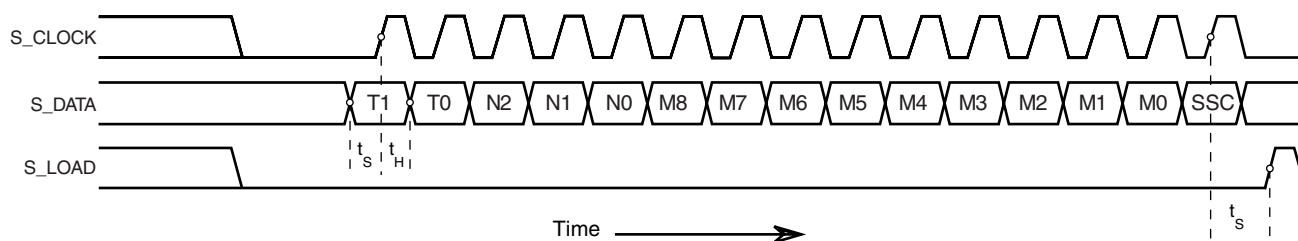
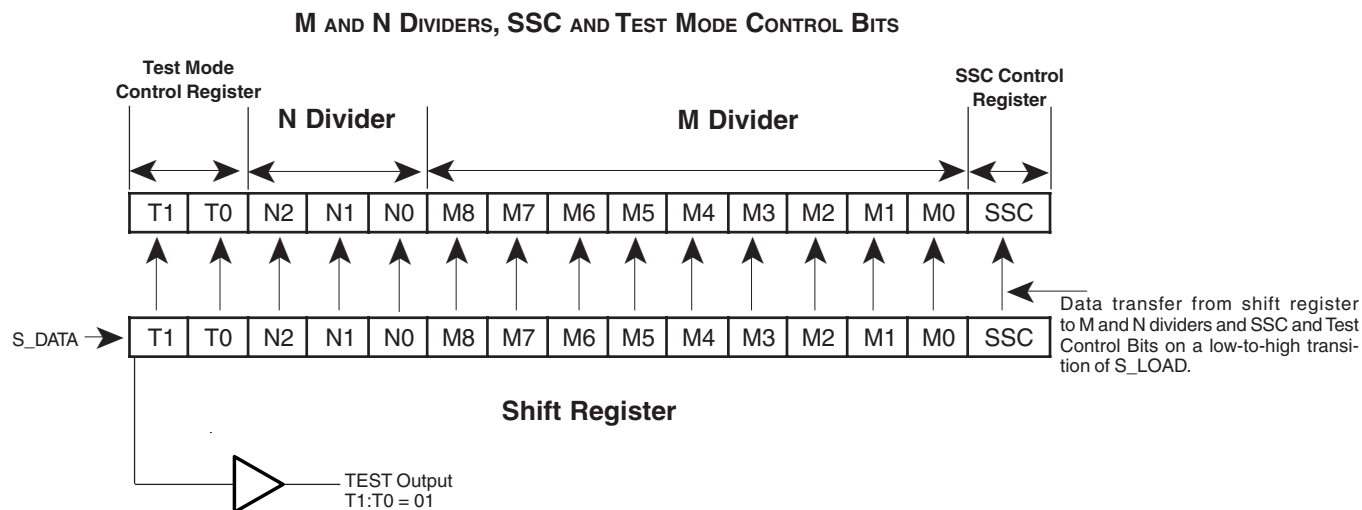


FIGURE 1. SERIAL LOAD OPERATIONS

**NOTE:** Default Output Frequency, using a 16.6667MHz crystal on power-up = 200MHz (M = 192, N = 2) SSC off

**TABLE 1. SSC FUNCTION TABLE**

| SSC | SSC State              |
|-----|------------------------|
| 0   | Off (power-up default) |
| 1   | 0.5% down-spread       |

**ICS8427-02 SHIFT REGISTER OPERATION – READ BACK CAPABILITY**

- Device powers up by default in Test Mode 01.  
The Test Output in this case is wired to the shift register.
- Shift in serial data stream and latch into M, N, T1, T0 and SSC Control Bits.  
Shift in T1:T0=00, so that the TEST Output will be turned off after the bits are shifted in and latched.

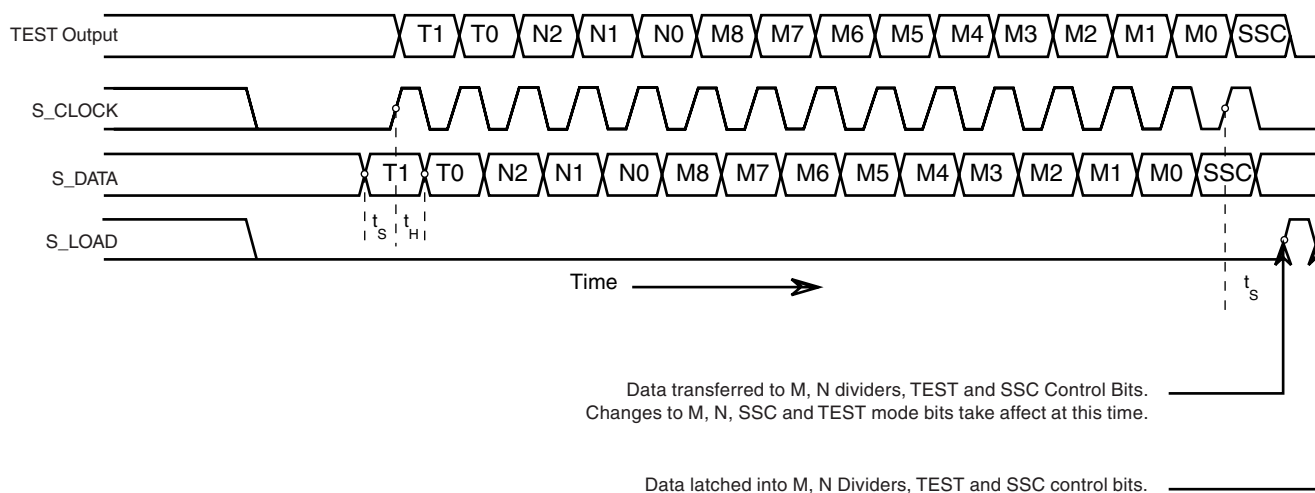


TABLE 2. PIN DESCRIPTIONS

| Number       | Name                 | Type   |          | Description                                                                                                                                                                                                                                                       |
|--------------|----------------------|--------|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1, 4, 13, 30 | V <sub>DDO</sub>     | Power  |          | Output supply pins.                                                                                                                                                                                                                                               |
| 2, 3         | FOUT2,<br>nFOUT2     | Output |          | Differential output pair. HSTL interface levels.                                                                                                                                                                                                                  |
| 5, 6         | FOUT3,<br>nFOUT3     | Output |          | Differential output pair. HSTL interface levels.                                                                                                                                                                                                                  |
| 7            | OE                   | Input  | Pullup   | Active High output enable. When HIGH, the outputs are enabled. When LOW, FOUTx = Low, nFOUTx = High. LVCMOS/LVTTL interface levels.                                                                                                                               |
| 8, 16        | GND                  | Power  |          | Power supply ground.                                                                                                                                                                                                                                              |
| 9            | TEST                 | Output |          | Test output which is ACTIVE in the serial mode of operation. LVCMOS/LVTTL interface levels.                                                                                                                                                                       |
| 10, 26       | V <sub>DD</sub>      | Power  |          | Core supply pins.                                                                                                                                                                                                                                                 |
| 11, 12       | FOUT4,<br>nFOUT4     | Output |          | Differential output pair. HSTL interface levels.                                                                                                                                                                                                                  |
| 14, 15       | FOUT5,<br>nFOUT5     | Output |          | Differential output pair. HSTL interface levels.                                                                                                                                                                                                                  |
| 17           | MR                   | Input  | Pulldown | Active High Master Reset. When logic HIGH, the internal dividers are reset causing the true outputs FOUTx to go low and the inverted outputs nFOUTx to go high. When logic LOW, the internal dividers and the outputs are enabled. LVCMOS/LVTTL interface levels. |
| 18           | S_CLOCK              | Input  | Pullup   | Input clock to load serial S_DATA into the shift register. LVCMOS/LVTTL interface levels.                                                                                                                                                                         |
| 19           | S_DATA               | Input  | Pullup   | Shift register serial input. Data sampled on the rising edge of S_CLOCK. LVCMOS/LVTTL interface levels.                                                                                                                                                           |
| 20           | S_LOAD               | Input  | Pulldown | Controls transition of data from shift register into the dividers. LVCMOS/LVTTL interface levels.                                                                                                                                                                 |
| 21           | V <sub>DDA</sub>     | Power  |          | Analog supply pin.                                                                                                                                                                                                                                                |
| 22           | XTAL_SEL             | Input  | Pullup   | Selects between XTAL input or test input as the PLL reference source. Selects XTAL input when HIGH. Selects TEST_CLK when LOW. LVCMOS/LVTTL interface levels.                                                                                                     |
| 23           | TEST_CLK             | Input  | Pulldown | Test clock input. LVCMOS/LVTTL interface levels.                                                                                                                                                                                                                  |
| 24, 25       | XTAL_OUT,<br>XTAL_IN | Input  |          | Crystal oscillator interface. XTAL_IN is the input. XTAL_OUT is the output.                                                                                                                                                                                       |
| 27           | VCO_SEL              | Input  | Pullup   | Determines whether synthesizer is in PLL or bypass mode. LVCMOS/LVTTL interface levels.                                                                                                                                                                           |
| 28, 29       | FOUT0,<br>nFOUT0     | Output |          | Differential output pair. HSTL interface levels.                                                                                                                                                                                                                  |
| 31, 32       | FOUT1,<br>nFOUT1     | Output |          | Differential output pair. HSTL interface levels.                                                                                                                                                                                                                  |

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 3. PIN CHARACTERISTICS

| Symbol                | Parameter               | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------------|-------------------------|-----------------|---------|---------|---------|-------|
| C <sub>IN</sub>       | Input Capacitance       |                 |         | 4       |         | pF    |
| R <sub>PULLUP</sub>   | Input Pullup Resistor   |                 |         | 51      |         | kΩ    |
| R <sub>PULLDOWN</sub> | Input Pulldown Resistor |                 |         | 51      |         | kΩ    |

TABLE 4A. CONTROL INPUT FUNCTION TABLE

| Inputs |          |                   | Outputs       |                |
|--------|----------|-------------------|---------------|----------------|
| OE     | XTAL_SEL | Selected Source   | FOUT0:FOUT5   | nFOUT0:nFOUT5  |
| 0      | 0        | TEST_CLK          | Disabled; LOW | Disabled; HIGH |
| 0      | 1        | XTAL_IN, XTAL_OUT | Disabled; LOW | Disabled; HIGH |
| 1      | 0        | TEST_CLK          | Enabled       | Enabled        |
| 1      | 1        | XTAL_IN, XTAL_OUT | Enabled       | Enabled        |

After OE switches, the clock outputs are disabled or enabled following a rising and falling VCO edge as shown in *Figure 2*.

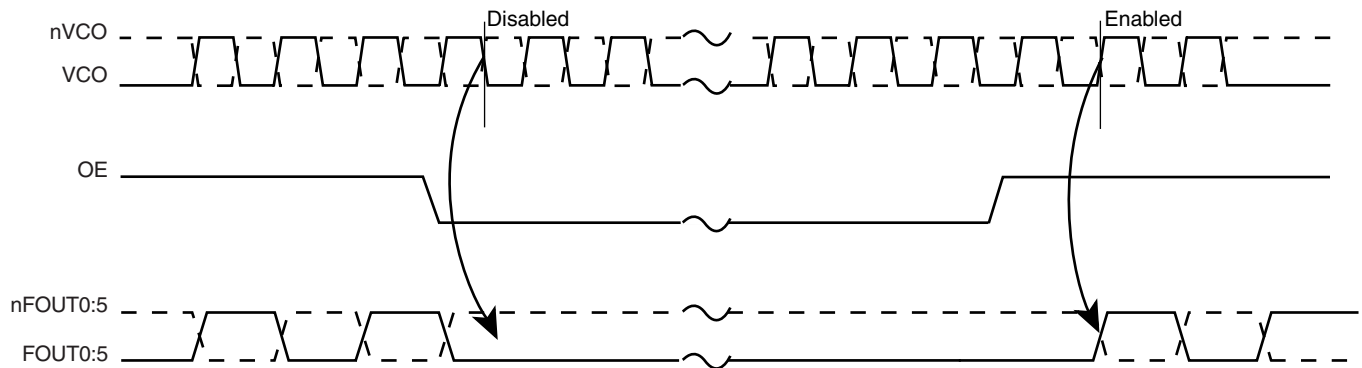


FIGURE 2. OE TIMING DIAGRAM

TABLE 4B. PROGRAMMABLE VCO FREQUENCY FUNCTION TABLE<sup>NOTE 1</sup>

| VCO Frequency (MHz) | M Divide | 256 | 128 | 64 | 32 | 16 | 8  | 4  | 2  | 1  |
|---------------------|----------|-----|-----|----|----|----|----|----|----|----|
|                     |          | M8  | M7  | M6 | M5 | M4 | M3 | M2 | M1 | M0 |
| 250                 | 120      | 0   | 0   | 1  | 1  | 1  | 1  | 0  | 0  | 0  |
| 252.08              | 121      | 0   | 0   | 1  | 1  | 1  | 1  | 0  | 0  | 1  |
| 254.17              | 122      | 0   | 0   | 1  | 1  | 1  | 1  | 0  | 1  | 0  |
| •                   | •        | •   | •   | •  | •  | •  | •  | •  | •  | •  |
| 400                 | 192      | 0   | 1   | 1  | 0  | 0  | 0  | 0  | 0  | 0  |
| •                   | •        | •   | •   | •  | •  | •  | •  | •  | •  | •  |
| 497.92              | 239      | 0   | 1   | 1  | 1  | 0  | 1  | 1  | 1  | 1  |
| 500                 | 240      | 0   | 1   | 1  | 1  | 1  | 0  | 0  | 0  | 0  |

NOTE 1: These M divide values and the resulting frequencies correspond to an input frequency of 16.6667MHz.

TABLE 4C. SERIAL MODE FUNCTION TABLE

| Inputs |        |         |        | Conditions                                                                                                        |
|--------|--------|---------|--------|-------------------------------------------------------------------------------------------------------------------|
| MR     | S_LOAD | S_CLOCK | S_DATA |                                                                                                                   |
| H      | X      | X       | X      | Reset. Forces outputs differential LOW. FOUTx = Low, nFOUTx = High.                                               |
| L      | L      | X       | X      | Data is latched into input registers and remains loaded until next LOW transition or until a serial event occurs. |
| L      | L      | ↑       | Data   | Serial input mode. Shift register is loaded with data on S_DATA on each rising edge of S_CLOCK.                   |
| L      | ↑      | L       | Data   | Contents of the shift register are passed to the M divider and N output divider.                                  |
| L      | ↓      | L       | Data   | M divider and N output divider values are latched.                                                                |
| L      | L      | X       | X      | Serial input do not affect shift registers.                                                                       |
| L      | H      | ↑       | Data   | S_DATA passed directly to M divider as it is clocked.                                                             |

NOTE: L = LOW

H = HIGH

X = Don't care

↑ = Rising edge transition

↓ = Falling edge transition

TABLE 4D. PROGRAMMABLE OUTPUT DIVIDER FUNCTION TABLE

| Input |    |    | N Divider Value | Output Frequency (MHz) |         |
|-------|----|----|-----------------|------------------------|---------|
| N2    | N1 | N0 |                 | Minimum                | Maximum |
| 0     | 0  | 0  | 2               | 125                    | 250     |
| 0     | 0  | 1  | 4               | 62.5                   | 125     |
| 0     | 1  | 0  | 8               | 31.25                  | 62.5    |
| 0     | 1  | 1  | 16              | 15.625                 | 31.25   |
| 1     | 0  | 0  | 1               | 250                    | 500     |
| 1     | 0  | 1  | 2               | 125                    | 250     |
| 1     | 1  | 0  | 4               | 62.5                   | 125     |
| 1     | 1  | 1  | 8               | 31.25                  | 62.5    |

**ABSOLUTE MAXIMUM RATINGS**

|                                          |                          |
|------------------------------------------|--------------------------|
| Supply Voltage, $V_{DD}$                 | 4.6V                     |
| Inputs, $V_I$                            | -0.5V to $V_{DD} + 0.5V$ |
| Outputs, $I_O$                           |                          |
| Continuous Current                       | 50mA                     |
| Surge Current                            | 100mA                    |
| Package Thermal Impedance, $\theta_{JA}$ |                          |
| for 32 Lead LQFP                         | 47.9°C/W (0 lfpm)        |
| for 32 Lead VFQFN                        | 34.8°C/W (0 lfpm)        |
| Storage Temperature, $T_{STG}$           | -65°C to 150°C           |

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

**TABLE 5A. POWER SUPPLY DC CHARACTERISTICS,  $V_{DD} = V_{DDA} = 2.5V \pm 5\%$ ,  $V_{DDO} = 1.8V \pm 0.2V$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$** 

| Symbol    | Parameter             | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------|-----------------------|-----------------|---------|---------|---------|-------|
| $V_{DD}$  | Core Supply           |                 | 2.375   | 2.5     | 2.625   | V     |
| $V_{DDA}$ | Analog Voltage        |                 | 2.375   | 2.5     | 2.625   | V     |
| $V_{DDO}$ | Output Voltage        |                 | 1.6     | 1.8     | 2.0     | V     |
| $I_{DD}$  | Power Supply Current  |                 |         |         | 175     | mA    |
| $I_{DDA}$ | Analog Supply Current |                 |         |         | 15      | mA    |
| $I_{DDO}$ | Output Supply Current | No Load         |         | 0       |         | mA    |

**TABLE 5B. LVCMOS/LVTTL DC CHARACTERISTICS,  $V_{DD} = V_{DDA} = 2.5V \pm 5\%$ ,  $V_{DDO} = 1.8V \pm 0.2V$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$** 

| Symbol   | Parameter           |                                        | Test Conditions                      | Minimum | Typical | Maximum        | Units   |
|----------|---------------------|----------------------------------------|--------------------------------------|---------|---------|----------------|---------|
| $V_{IH}$ | Input High Voltage  |                                        |                                      | 1.7     |         | $V_{DD} + 0.3$ | V       |
| $V_{IL}$ | Input Low Voltage   |                                        |                                      | -0.3    |         | 0.7            | V       |
| $I_{IH}$ | Input High Current  | MR, S_LOAD, TEST_CLK                   | $V_{DD} = V_{IN} = 2.625V$           |         |         | 150            | $\mu A$ |
|          |                     | XTAL_SEL, VCO_SEL, S_CLOCK, S_DATA, OE | $V_{DD} = V_{IN} = 2.625V$           |         |         | 5              | $\mu A$ |
| $I_{IL}$ | Input Low Current   | MR, S_LOAD, TEST_CLK                   | $V_{DD} = 2.625V$ ,<br>$V_{IN} = 0V$ | -5      |         |                | $\mu A$ |
|          |                     | XTAL_SEL, VCO_SEL, S_CLOCK, S_DATA, OE | $V_{DD} = 2.625V$ ,<br>$V_{IN} = 0V$ | -150    |         |                | $\mu A$ |
| $V_{OH}$ | Output High Voltage | TEST; NOTE 1                           |                                      | 1.5     |         |                | V       |
| $V_{OL}$ | Output Low Voltage  | TEST; NOTE 1                           |                                      |         |         | 0.4            | V       |

NOTE 1: Outputs terminated with  $50\Omega$  to  $V_{DDO}/2$ .

**TABLE 5C. LVHSTL DC CHARACTERISTICS**,  $V_{DD} = V_{DDA} = 2.5V \pm 5\%$ ,  $V_{DDO} = 1.8V \pm 0.2V$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$ 

| Symbol      | Parameter                         | Test Conditions | Minimum | Typical | Maximum | Units |
|-------------|-----------------------------------|-----------------|---------|---------|---------|-------|
| $V_{OH}$    | Output High Voltage; NOTE 1       |                 | 0.9     |         | 1.3     | V     |
| $V_{OL}$    | Output Low Voltage; NOTE 1        |                 | 0       |         | 0.4     | V     |
| $V_{OX}$    | Output Crossover Voltage; NOTE 2  |                 | 40      |         | 60      | %     |
| $V_{SWING}$ | Peak-to-Peak Output Voltage Swing |                 | 0.6     |         | 1.1     | V     |

NOTE 1: Outputs terminated with  $50\Omega$  to GND. See 2.5V Output Load Test Circuit figure in the Parameter Measurement Information section.

NOTE 2: Defined with respect to output voltage swing at a given condition.

**TABLE 6. CRYSTAL CHARACTERISTICS**

| Parameter                          | Test Conditions | Minimum     | Typical | Maximum | Units    |
|------------------------------------|-----------------|-------------|---------|---------|----------|
| Mode of Oscillation                |                 | Fundamental |         |         |          |
| Frequency                          |                 | 12          |         | 40      | MHz      |
| Equivalent Series Resistance (ESR) |                 |             |         | 50      | $\Omega$ |
| Shunt Capacitance                  |                 |             |         | 7       | pF       |
| Drive Level                        |                 |             |         | 1       | mW       |

**TABLE 7. INPUT CHARACTERISTICS**,  $V_{DD} = V_{DDA} = 2.5V \pm 5\%$ ,  $V_{DDO} = 1.8V \pm 0.2V$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$ 

| Symbol         | Parameter       |              | Test Conditions              | Minimum | Typical | Maximum | Units |
|----------------|-----------------|--------------|------------------------------|---------|---------|---------|-------|
| $f_{IN}$       | Input Frequency | TEST_CLK     | VCO select = 1               | 12      |         | 40      | MHz   |
|                |                 |              | VCO select = 0 (bypass mode) |         |         | 400     | MHz   |
|                |                 | XTAL; NOTE 1 |                              | 12      |         | 40      | MHz   |
|                |                 | S_CLOCK      |                              |         |         | 50      | MHz   |
| $t_{F\_INPUT}$ | Input Rise Time | TEST_CLK     |                              |         |         | 5       | ns    |

NOTE 1: For the crystal frequency range the M value must be set to achieve the minimum or maximum VCO frequency range of 250MHz or 500MHz. Using the minimum frequency of 12MHz valid values of M are  $167 \leq M \leq 256$ . Using the maximum frequency of 40MHz valid values of M are  $50 \leq M \leq 100$ .

**TABLE 8. AC CHARACTERISTICS,  $V_{DD} = V_{DDA} = 2.5V \pm 5\%$ ,  $V_{DDO} = 1.8V \pm 0.2V$ ,  $T_A = 0^\circ C$  TO  $70^\circ C$** 

| Symbol          | Parameter                           | Test Conditions    | Minimum | Typical | Maximum | Units |
|-----------------|-------------------------------------|--------------------|---------|---------|---------|-------|
| $F_{MAX}$       | Output Frequency                    |                    |         |         | 500     | MHz   |
| $f_{jit(cc)}$   | Cycle-to-Cycle Jitter; NOTE 1, 3    | $F_{OUT} = 200MHz$ |         | 30      | 50      | ps    |
|                 |                                     | $F_{OUT} = 267MHz$ |         | 30      | 50      | ps    |
|                 |                                     | $F_{OUT} = 333MHz$ |         | 30      | 50      | ps    |
|                 |                                     | $F_{OUT} = 400MHz$ |         | 30      | 50      | ps    |
| $f_{jitt}(T50)$ | T50 Cycle Jitter                    | $F_{OUT} = 200MHz$ |         |         | 200     | ps    |
|                 |                                     | $F_{OUT} = 267MHz$ |         |         | 200     | ps    |
|                 |                                     | $F_{OUT} = 333MHz$ |         |         | 200     | ps    |
|                 |                                     | $F_{OUT} = 400MHz$ |         |         | 200     | ps    |
| $f_{jit(per)}$  | Period Jitter, RMS; NOTE 1          |                    |         | 2.5     | 5       | ps    |
| $t_{sk(o)}$     | Output Skew; NOTE 2, 3              |                    |         | 65      | 100     | ps    |
| $F_M$           | SSC Modulation Frequency; NOTE 4, 5 | $F_{OUT} = 200MHz$ | 30      |         | 33.33   | kHz   |
|                 |                                     | $F_{OUT} = 267MHz$ | 30      |         | 33.33   | kHz   |
|                 |                                     | $F_{OUT} = 333MHz$ | 30      |         | 33.33   | kHz   |
|                 |                                     | $F_{OUT} = 400MHz$ | 30      |         | 33.33   | kHz   |
| $F_{MF}$        | SSC Modulation Factor; NOTE 4, 5    | $F_{OUT} = 200MHz$ |         | 0.3     | 0.6     | %     |
|                 |                                     | $F_{OUT} = 267MHz$ |         | 0.4     | 0.6     | %     |
|                 |                                     | $F_{OUT} = 333MHz$ |         | 0.3     | 0.6     | %     |
|                 |                                     | $F_{OUT} = 400MHz$ |         | 0.3     | 0.6     | %     |
| $SSC_{red}$     | Spectral Reduction; NOTE 4, 5       | $F_{OUT} = 200MHz$ | -7      | -10     |         | dB    |
|                 |                                     | $F_{OUT} = 267MHz$ | -7      | -12     |         | dB    |
|                 |                                     | $F_{OUT} = 333MHz$ | -7      | -11     |         | dB    |
|                 |                                     | $F_{OUT} = 400MHz$ | -7      | -12     |         | dB    |
| $Ref_{spur}$    | Reference Spur                      | $F_{OUT} = 200MHz$ |         | -40     |         | dB    |
|                 |                                     | $F_{OUT} = 267MHz$ |         | -40     |         | dB    |
|                 |                                     | $F_{OUT} = 333MHz$ |         | -45     |         | dB    |
|                 |                                     | $F_{OUT} = 400MHz$ |         | -50     |         | dB    |
| $t_R / t_F$     | Output Rise/Fall Time               | 20% to 80%         | 333     |         | 667     | ps    |
| $t_S$           | Setup Time                          | S_DATA to S_CLOCK  | 5       |         |         | ns    |
|                 |                                     | S_CLOCK to S_LOAD  | 5       |         |         | ns    |
| $t_H$           | Hold Time                           | S_DATA to S_CLOCK  | 5       |         |         | ns    |
|                 |                                     | S_CLOCK to S_LOAD  | 5       |         |         | ns    |
| $odc$           | Output Duty Cycle                   | N = 1              | 40      |         | 60      | %     |
|                 |                                     | N = 2              | 45      |         | 55      | %     |
| $t_{LOCK}$      | PLL Lock Time                       |                    |         |         | 1       | ms    |

See Parameter Measurement Information section.

NOTE 1: Jitter performance using XTAL inputs.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.

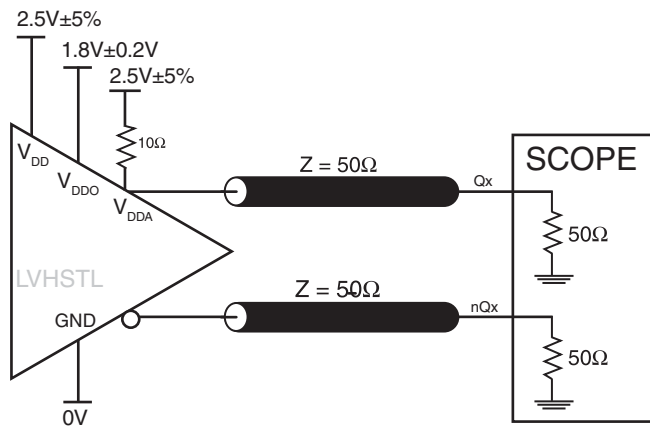
Measured at the output differential cross points.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.

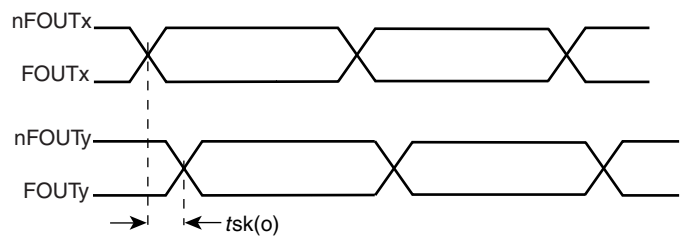
NOTE 4: Spread Spectrum clocking enabled.

NOTE 5: Using a 16.6667MHz quartz crystal.

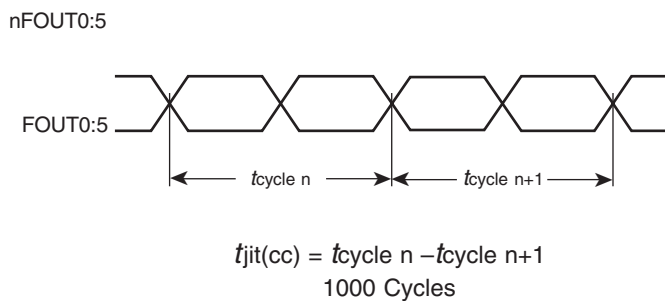
## PARAMETER MEASUREMENT INFORMATION



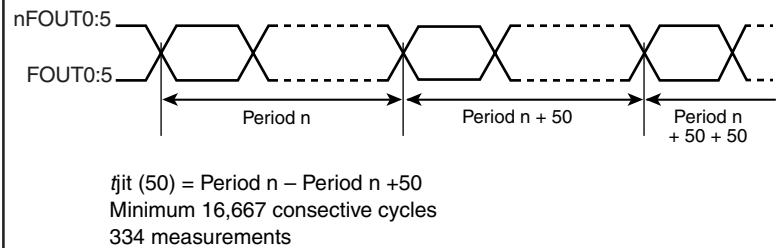
**2.5V CORE/1.8V OUTPUT LOAD AC TEST CIRCUIT**



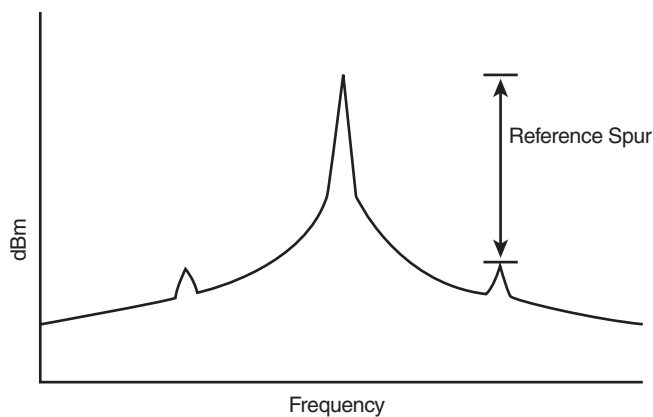
**OUTPUT SKEW**



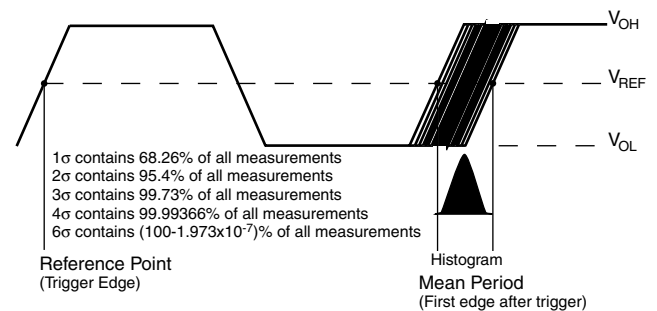
**CYCLE-TO-CYCLE JITTER**



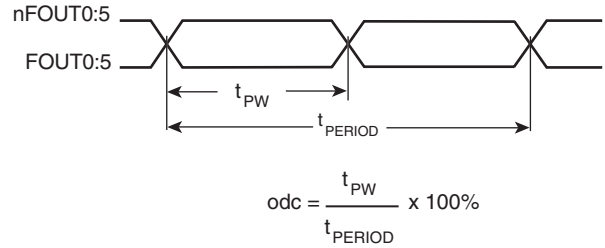
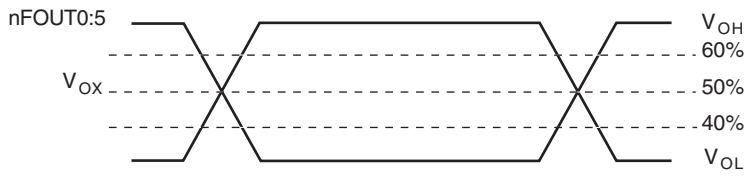
**T50 CYCLE-TO-CYCLE JITTER**



**SPUR REDUCTION**

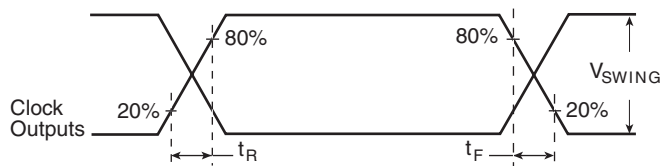


**PERIOD JITTER**



### OUTPUT CROSSOVER VOLTAGE

### OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD



### OUTPUT RISE/FALL TIME

## APPLICATION INFORMATION

### POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS8427-02 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL.  $V_{DD}$ ,  $V_{DDA}$ , and  $V_{DDO}$  should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. *Figure 3* illustrates how a  $10\Omega$  resistor along with a  $10\mu F$  and a  $.01\mu F$  bypass capacitor should be connected to each  $V_{DDA}$  pin.

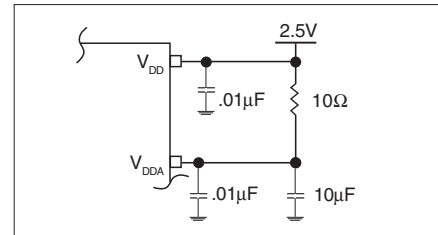


FIGURE 3. POWER SUPPLY FILTERING

### RECOMMENDATIONS FOR UNUSED INPUT AND OUTPUT PINS

#### INPUTS:

##### CRYSTAL INPUT:

For applications not requiring the use of the crystal oscillator input, both XTAL\_IN and XTAL\_OUT can be left floating. Though not required, but for additional protection, a  $1k\Omega$  resistor can be tied from XTAL\_IN to ground.

##### TEST\_CLK INPUT:

For applications not requiring the use of the test clock, it can be left floating. Though not required, but for additional protection, a  $1k\Omega$  resistor can be tied from the TEST\_CLK to ground.

##### LVCMOS CONTROL PINS:

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A  $1k\Omega$  resistor can be used.

#### OUTPUTS:

##### LVHSTL OUTPUT

All unused LVHSTL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

## CRYSTAL INPUT INTERFACE

The ICS8427-02 has been characterized with 18pF parallel resonant crystals. The capacitor values, C1 and C2, shown in Figure 4 below were determined using a 16.66MHz, 18pF parallel

resonant crystal and were chosen to minimize the ppm error. The optimum C1 and C2 values can be slightly adjusted for different board layouts.

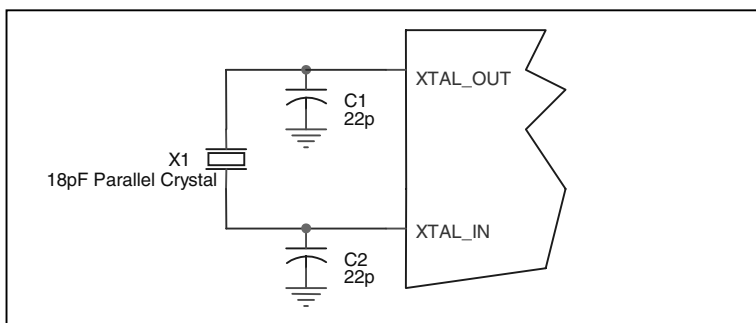


Figure 4. CRYSTAL INPUT INTERFACE

## LVCMOS TO XTAL INTERFACE

The XTAL\_IN input can accept a single-ended LVCMOS signal through an AC coupling capacitor. A general interface diagram is shown in Figure 5. The XTAL\_OUT pin can be left floating. The input edge rate can be as slow as 10ns. For LVCMOS inputs, it is recommended that the amplitude be reduced from full swing to half swing in order to prevent signal interference with the power rail and to reduce noise. This configuration requires that the output impedance of the driver ( $R_o$ ) plus the series resistance ( $R_s$ ) equals

the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This can be done in one of two ways. First, R1 and R2 in parallel should equal the transmission line impedance. For most 50Ω applications, R1 and R2 can be 100Ω. This can also be accomplished by removing R1 and making R2 50Ω.

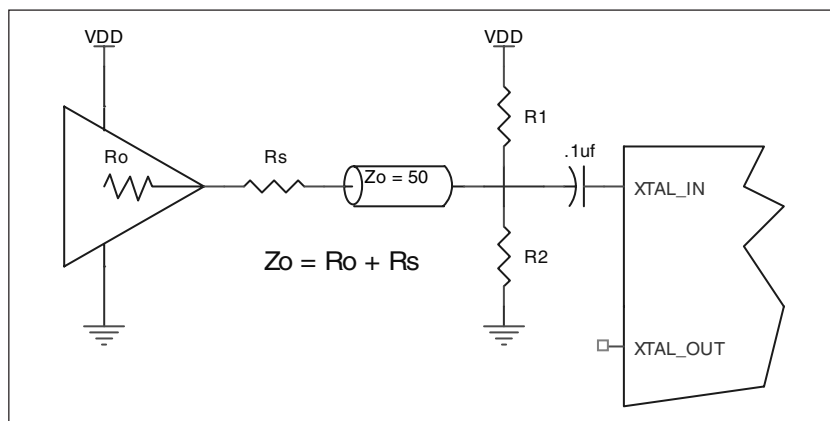


FIGURE 5. GENERAL DIAGRAM FOR LVCMOS DRIVER TO XTAL INPUT INTERFACE

## THERMAL RELEASE PATH

The expose metal pad provides heat transfer from the device to the P.C. board. The expose metal pad is ground pad connected to ground plane through thermal via. The exposed pad on the device to the exposed metal pad on the PCB is contacted through

solder as shown in *Figure 6*. For further information, please refer to the Application Note on Surface Mount Assembly of Amkor's Thermally/Electrically Enhance Leadframe Base Package, Amkor Technology.

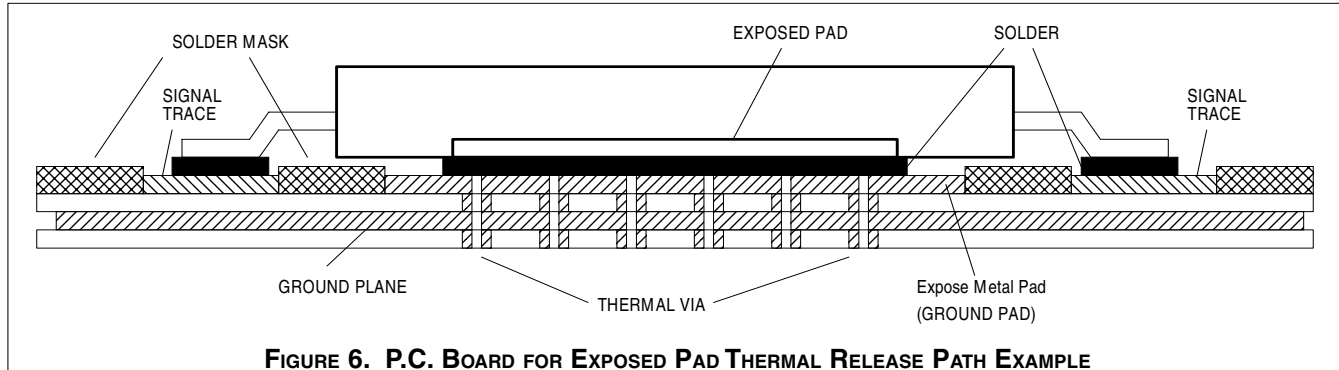


FIGURE 6. P.C. BOARD FOR EXPOSED PAD THERMAL RELEASE PATH EXAMPLE

## SPREAD SPECTRUM

Spread-spectrum clocking is a frequency modulation technique for EMI reduction. When spread-spectrum is enabled, a 32.55kHz triangle waveform is used with 0.5% down-spread (+0.0%/-0.5%) from the nominal 200MHz clock frequency. An example of a triangle frequency modulation profile is shown in *Figure 5A* below. The ramp profile can be expressed as:

- $F_{nom}$  = Nominal Clock Frequency in Spread OFF mode (200MHz with 16.6667MHz IN)
- $F_m$  = Nominal Modulation Frequency  
= Reference Frequency  
16 x 32
- $\delta$  = Modulation Factor (0.5% down spread)

$$(1 - \delta) f_{nom} + 2 f_m \times \delta \times f_{nom} \times t \text{ when } 0 < t < \frac{1}{2 f_m},$$

$$(1 - \delta) f_{nom} - 2 f_m \times \delta \times f_{nom} \times t \text{ when } \frac{1}{2 f_m} < t < \frac{1}{f_m}$$

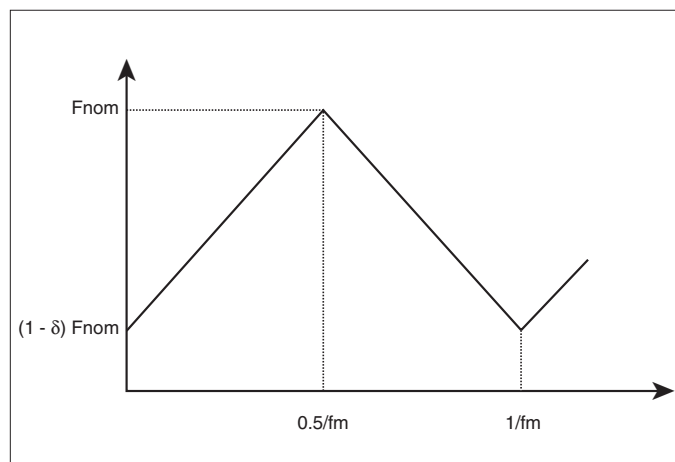


FIGURE 7A. TRIANGLE FREQUENCY MODULATION

The ICS8427-02 triangle modulation frequency deviation will not exceed 0.6% down-spread from the nominal clock frequency (+0.0% / -0.5%). An example of the amount of down spread relative to the nominal clock frequency can be seen in the frequency domain, as shown in *Figure 7B*. The ratio of this width to the fundamental frequency is typically 0.4%, and will not exceed 0.6%. The resulting spectral reduction will be greater than 7dB, as shown in *Figure 7B*. It is important to note the ICS8427-02 7dB minimum spectral reduction is the component-specific EMI reduction, and will not necessarily be the same as the system EMI reduction.

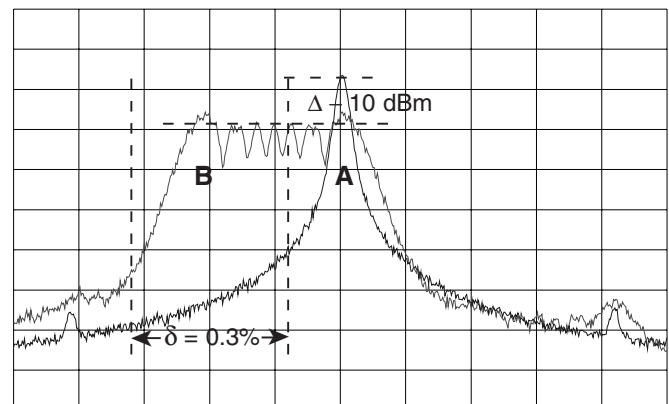


FIGURE 7B. 200MHz CLOCK OUTPUT IN FREQUENCY DOMAIN

(A) SPREAD-SPECTRUM OFF  
(B) SPREAD-SPECTRUM ON

**LAYOUT GUIDELINE**

Figure 8 shows an application schematic example of the ICS8427-02. In this example, a 16.6667MHz, 18pF parallel resonant crystal is used. The C1=22pF and C2=22pF are

approximate values for frequency accuracy. The C1 and C2 may be slightly adjusted for optimizing frequency accuracy.

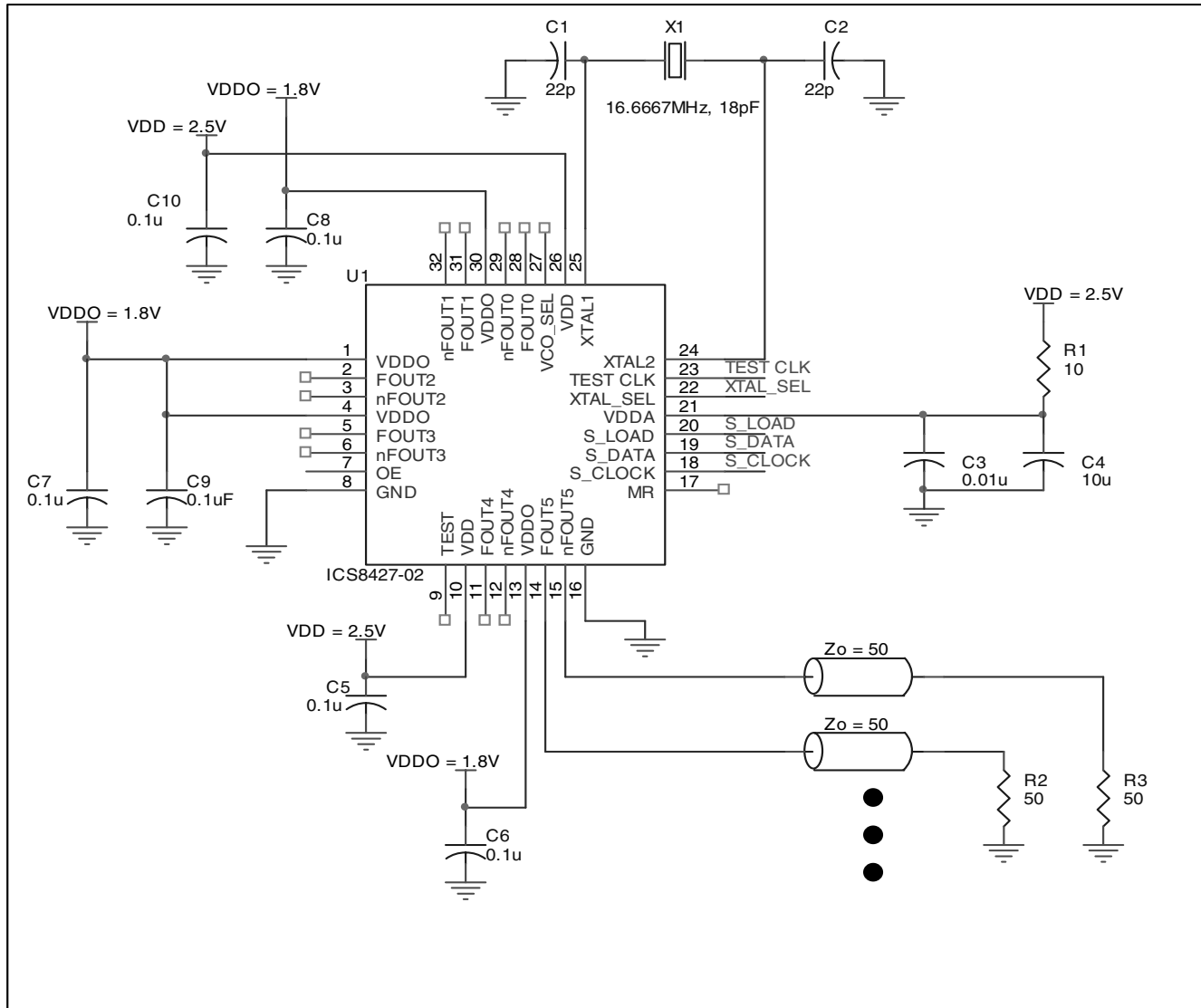


FIGURE 8. SCHEMATIC OF RECOMMENDED LAYOUT

## POWER CONSIDERATIONS

This section provides information on power dissipation and junction temperature for the ICS8427-02. Equations and example calculations are also provided.

### 1. Power Dissipation.

The total power dissipation for the ICS8427-02 is the sum of the core power plus the power dissipated in the load(s). The following is the power dissipation for  $V_{DD} = 2.5V + 5\% = 2.625V$ , which gives worst case results.

**NOTE:** Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)<sub>MAX</sub> =  $V_{DD\_MAX} * I_{DD\_MAX} = 2.625V * 175mA = 459.4mW$
- Power (outputs)<sub>MAX</sub> = **32.6mW/Loaded Output pair**  
If all outputs are loaded, the total power is  $6 * 32.6mW = 195.6mW$

$$\text{Total Power}_{MAX} (3.465V, \text{ with all outputs switching}) = 459.37mW + 195.6mW = 655mW$$

### 2. Junction Temperature.

Junction temperature,  $T_j$ , is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS™ devices is 125°C.

The equation for  $T_j$  is as follows:  $T_j = \theta_{JA} * Pd\_total + T_A$

$T_j$  = Junction Temperature

$\theta_{JA}$  = Junction-to-Ambient Thermal Resistance

$Pd\_total$  = Total Device Power Dissipation (example calculation is in section 1 above)

$T_A$  = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming a moderate air flow of 200 linear feet per minute and a multi-layer board, the appropriate value is 42.1°C/W per Table 9A below.

Therefore,  $T_j$  for an ambient temperature of 70°C with all outputs switching is:

$$70^\circ C + 0.655W * 42.1^\circ C/W = 97.6^\circ C. \text{ This is well below the limit of } 125^\circ C.$$

This calculation is only an example.  $T_j$  will obviously vary depending on the number of loaded outputs, supply voltage, air flow, and the type of board (single layer or multi-layer).

**TABLE 9A. THERMAL RESISTANCE  $\theta_{JA}$  FOR 32-PIN LQFP, FORCED CONVECTION**

| $\theta_{JA}$ by Velocity (Linear Feet per Minute) |          |          |          |
|----------------------------------------------------|----------|----------|----------|
|                                                    | 0        | 200      | 500      |
| Single-Layer PCB, JEDEC Standard Test Boards       | 67.8°C/W | 55.9°C/W | 50.1°C/W |
| Multi-Layer PCB, JEDEC Standard Test Boards        | 47.9°C/W | 42.1°C/W | 39.4°C/W |

**NOTE:** Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

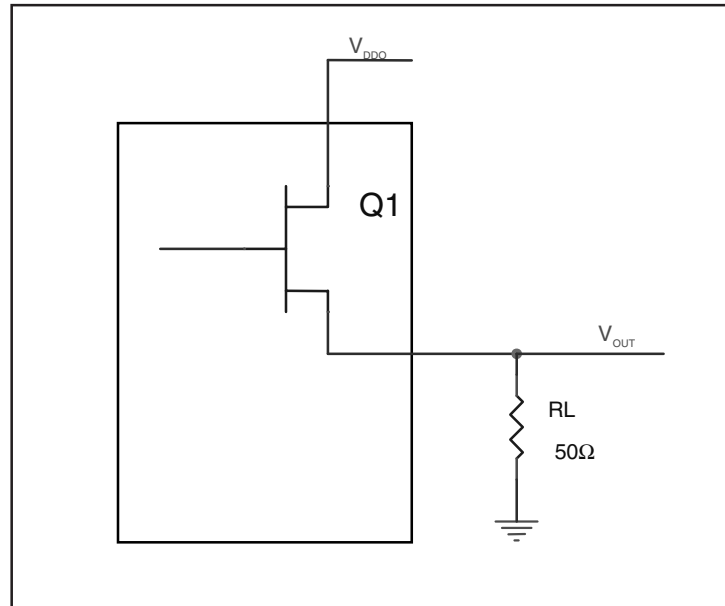
**TABLE 9B.  $\theta_{JA}$  vs. AIR FLOW TABLE FOR A 32 LEAD VFQFN**

| $\theta_{JA}$ 0 Air Flow (Linear Feet per Minute) |          |
|---------------------------------------------------|----------|
|                                                   | 0        |
| Multi-Layer PCB, JEDEC Standard Test Boards       | 34.8°C/W |

### 3. Calculations and Equations.

The purpose of this section is to derive the power dissipated into the load.

LVHSTL output driver circuit and termination are shown in *Figure 9*.



**FIGURE 9. LVHSTL DRIVER CIRCUIT AND TERMINATION**

To calculate worst case power dissipation into the load, use the following equations which assume a 50Ω load.

Pd\_H is power dissipation when the output drives high.

Pd\_L is the power dissipation when the output drives low.

$$Pd_H = (V_{OH\_MIN} / R_L) * (V_{DD\_MAX} - V_{OH\_MIN})$$

$$Pd_L = (V_{OL\_MAX} / R_L) * (V_{DD\_MAX} - V_{OL\_MAX})$$

$$Pd_H = (0.9V / 50\Omega) * (2V - 0.9V) = \mathbf{19.8mW}$$

$$Pd_L = (0.4V / 50\Omega) * (2V - 0.4V) = \mathbf{12.8mW}$$

$$\text{Total Power Dissipation per output pair} = Pd_H + Pd_L = \mathbf{32.6mW}$$

## RELIABILITY INFORMATION

**TABLE 10A.  $\theta_{JA}$  VS. AIR FLOW TABLE FOR 32 LEAD LQFP**

| $\theta_{JA}$ by Velocity (Linear Feet per Minute)                                                                  |          |          |          |
|---------------------------------------------------------------------------------------------------------------------|----------|----------|----------|
|                                                                                                                     | 0        | 200      | 500      |
| Single-Layer PCB, JEDEC Standard Test Boards                                                                        | 67.8°C/W | 55.9°C/W | 50.1°C/W |
| Multi-Layer PCB, JEDEC Standard Test Boards                                                                         | 47.9°C/W | 42.1°C/W | 39.4°C/W |
| <b>NOTE:</b> Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs. |          |          |          |

**TABLE 10B.  $\theta_{JA}$  VS. AIR FLOW TABLE FOR A 32 LEAD VFQFN**

| $\theta_{JA}$ 0 Air Flow (Linear Feet per Minute) |          |
|---------------------------------------------------|----------|
|                                                   | 0        |
| Multi-Layer PCB, JEDEC Standard Test Boards       | 34.8°C/W |

### TRANSISTOR COUNT

The transistor count for ICS8427-02 is: 4585

## PACKAGE OUTLINE - Y SUFFIX FOR 32 LEAD LQFP

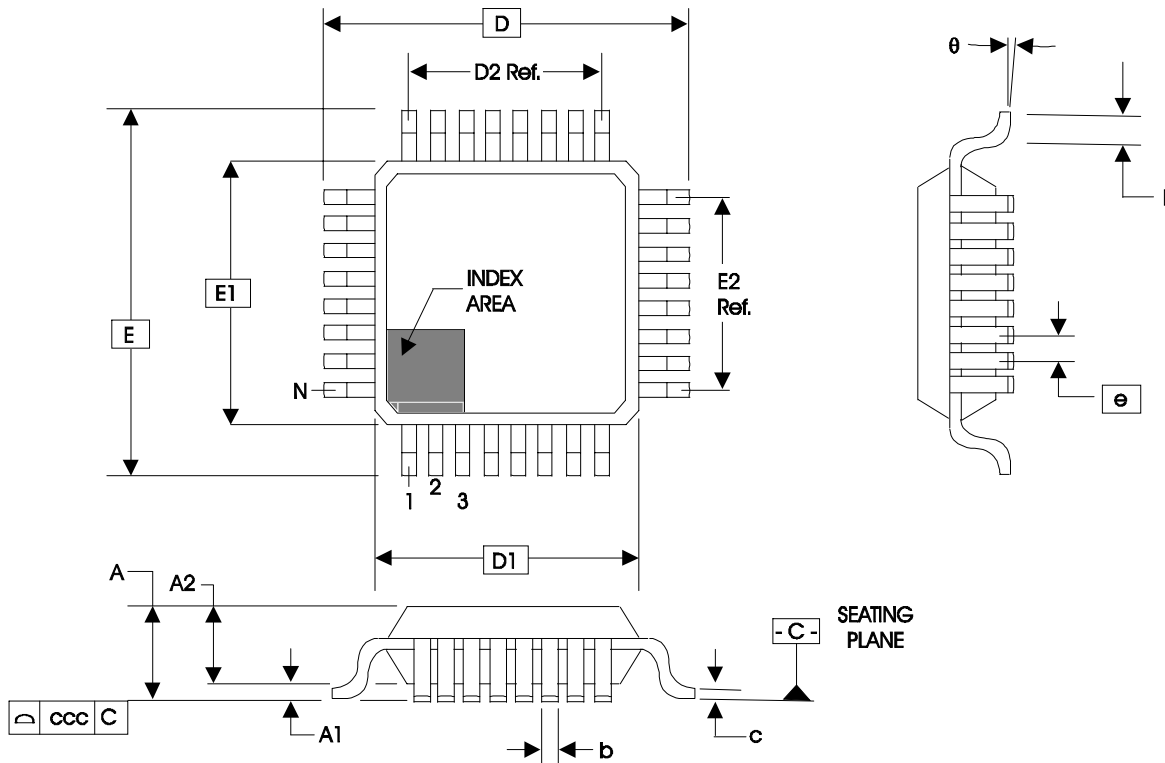


TABLE 11A. PACKAGE DIMENSIONS

| JEDEC VARIATION<br>ALL DIMENSIONS IN MILLIMETERS |         |            |         |
|--------------------------------------------------|---------|------------|---------|
| SYMBOL                                           | BBA     |            |         |
|                                                  | MINIMUM | NOMINAL    | MAXIMUM |
| N                                                | 32      |            |         |
| A                                                |         |            | 1.60    |
| A1                                               | 0.05    |            | 0.15    |
| A2                                               | 1.35    | 1.40       | 1.45    |
| b                                                | 0.30    | 0.37       | 0.45    |
| c                                                | 0.09    |            | 0.20    |
| D                                                |         | 9.00 BASIC |         |
| D1                                               |         | 7.00 BASIC |         |
| D2                                               |         | 5.60       |         |
| E                                                |         | 9.00 BASIC |         |
| E1                                               |         | 7.00 BASIC |         |
| E2                                               |         | 5.60       |         |
| e                                                |         | 0.80 BASIC |         |
| L                                                | 0.45    | 0.60       | 0.75    |
| q                                                | 0°      |            | 7°      |
| ccc                                              |         |            | 0.10    |

Reference Document: JEDEC Publication 95, MS-026

## PACKAGE OUTLINE - K SUFFIX FOR A 32 LEAD VFQFN

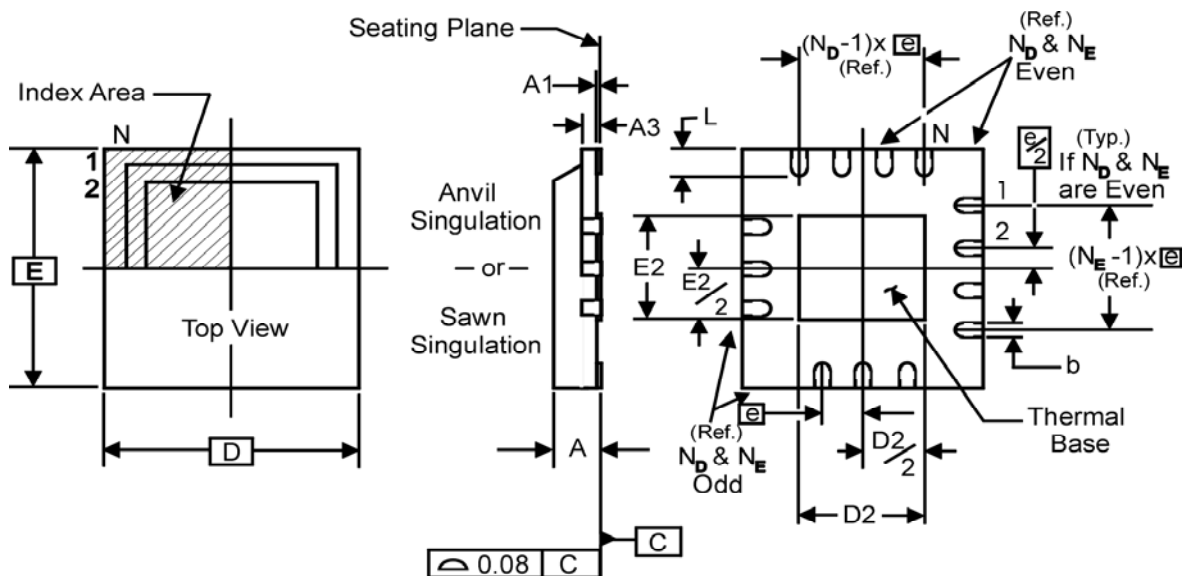


TABLE 11B. PACKAGE DIMENSIONS

| JEDEC VARIATION<br>ALL DIMENSIONS IN MILLIMETERS |            |         |         |
|--------------------------------------------------|------------|---------|---------|
| SYMBOL                                           | VHHD-2     |         |         |
|                                                  | MINIMUM    | NOMINAL | MAXIMUM |
| N                                                | 32         |         |         |
| A                                                | 0.80       | --      | 1.00    |
| A1                                               | 0          | --      | 0.05    |
| A3                                               | 0.25 Ref.  |         |         |
| b                                                | 0.18       | 0.25    | 0.30    |
| N <sub>D</sub>                                   |            |         | 8       |
| N <sub>E</sub>                                   |            |         | 8       |
| D                                                | 5.00 BASIC |         |         |
| D2                                               | 1.25       | 2.25    | 3.25    |
| E                                                | 5.00 BASIC |         |         |
| E2                                               | 1.25       | 2.25    | 3.25    |
| e                                                | 0.50 BASIC |         |         |
| L                                                | 0.30       | 0.40    | 0.50    |

Reference Document: JEDEC Publication 95, MO-220

TABLE 12. ORDERING INFORMATION

| Part/Order Number | Marking      | Package                   | Shipping Packaging | Temperature |
|-------------------|--------------|---------------------------|--------------------|-------------|
| ICS8427DY-02      | ICS8427DY-02 | 32 Lead LQFP              | tray               | 0°C to 70°C |
| ICS8427DY-02T     | ICS8427DY-02 | 32 Lead LQFP              | 1000 tape & reel   | 0°C to 70°C |
| ICS8427DY-02LF    | ICS8427DY02L | 32 Lead "Lead-Free" LQFP  | tray               | 0°C to 70°C |
| ICS8427DY-02LFT   | ICS8427DY02L | 32 Lead "Lead-Free" LQFP  | 1000 tape & reel   | 0°C to 70°C |
| ICS8427DK-02      | ICS8427DK-02 | 32 Lead VFQFN             | tray               | 0°C to 70°C |
| ICS8427DK-02T     | ICS8427DK-02 | 32 Lead VFQFN             | 2500 tape & reel   | 0°C to 70°C |
| ICS8427DK-02LF    | TBD          | 32 Lead "Lead-Free" VFQFN | tray               | 0°C to 70°C |
| ICS8427DK-02LFT   | TBD          | 32 Lead "Lead-Free" VFQFN | 2500 tape & reel   | 0°C to 70°C |

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

While the information presented herein has been checked for both accuracy and reliability, Integrated Device Technology, Incorporated (IDT) assumes no responsibility for either its use or for infringement of any patents or other rights of third parties, which would result from its use. No other circuits, patents, or licenses are implied. This product is intended for use in normal commercial applications. Any other applications such as those requiring extended temperature ranges, high reliability or other extraordinary environmental requirements are not recommended without additional processing by IDT. IDT reserves the right to change any circuitry or specifications without notice. IDT does not authorize or warrant any IDT product for use in life support devices or critical medical instruments.

## REVISION HISTORY SHEET

| Rev | Table | Page | Description of Change                                                  | Date     |
|-----|-------|------|------------------------------------------------------------------------|----------|
| A   | T11   | 10   | Updated Output Load AC Test Circuit diagram.                           | 2/17/06  |
|     |       | 20   | Ordering Information Table - added lead-free marking for LQFP package. |          |
| A   | T1    | 3    | Added SSC Function Table.                                              | 10/13/06 |
|     |       | 13   | Added <i>LVCMOS to XTAL Interface</i> .                                |          |
|     |       | 14   | Added <i>Thermal Release Path</i> .                                    |          |
|     |       |      |                                                                        |          |

**Innovate with IDT and accelerate your future networks. Contact:**

**www.IDT.com**

**For Sales**

800-345-7015  
408-284-8200  
Fax: 408-284-2775

**For Tech Support**

netcom@idt.com  
480-763-2056

---

**Corporate Headquarters**

Integrated Device Technology, Inc.  
6024 Silver Creek Valley Road  
San Jose, CA 95138  
United States  
800 345 7015  
+408 284 8200 (outside U.S.)

**Asia Pacific and Japan**

Integrated Device Technology  
Singapore (1997) Pte. Ltd.  
Reg. No. 199707558G  
435 Orchard Road  
#20-03 Wisma Atria  
Singapore 238877  
+65 6 887 5505

**Europe**

IDT Europe, Limited  
321 Kingston Road  
Leatherhead, Surrey  
KT22 7TU  
England  
+44 (0) 1372 363 339  
Fax: +44 (0) 1372 378851